

Notice of References Cited	Application/Control No. 10/712,245	Applicant(s)/Patent Under Reexamination HSIAO, SHIH-SHIEN	
	Examiner Duc M. Nguyen	Art Unit 2685	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,795,715 B1	09-2004	Kubo et al.	455/556.1
*	B	US-2004/0230789 A1	11-2004	Lee, Pu-Yun	713/002
*	C	US-2004/0087350 A1	05-2004	Nagasawa, Makoto	455/572
*	D	US-2005/0037647 A1	02-2005	Le, Trung V.	439/131
*	E	US-5,612,732 A	03-1997	Yuyama et al.	348/14.01
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 407046526A	02-1995	JP	Hayashi et al	H04N 005/91
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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